

<b>Issue Classification</b>				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/735,916		GOETSCH ET AL.	
Examiner				Art Unit			
Phuong Huynh				1644			

<b>ISSUE CLASSIFICATION</b>							
ORIGINAL			CROSS REFERENCE(S)				
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
424	130.1	424	133.1	134.1	135.1	141.1	143.1
INTERNATIONAL CLASSIFICATION			425	7.1	810		
C	0	7	K	16/28	530	387.1	387.3
C	1	2	P	21/08			
A	6	1	K	39/395			
A	6	1	K	39/00			
G	0	1	N	33/53			
Phuong Huynh 3/2/07 (Assistant Examiner) (Date)			Christina Chan CHRISTINA CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1600 (Primary Examiner) (Date) 3/5/07			Total Claims Allowed: 17	
Goodwin 5-3-07 (Legal Instruments Examiner) (Date)						O.G. Print Claim(s) 1	O.G. Print Fig. None

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	3	61	9	91	121	151
2		32	62	10	92	122	152
3		33	63	11	93	123	153
4		34	64	12	94	124	154
5		35	65	13	95	125	155
6		36	66	66	96	126	156
7		37	67	67	97	127	157
8		38	68	68	98	128	158
9		39	69	69	99	129	159
10		40	70	70	100	130	160
11		41	71	71	101	131	161
12		42	72	72	102	132	162
13		43	73	17	103	133	163
14		44	74	14	104	134	164
15		45	75	15	105	135	165
16		46	76	16	106	136	166
17		47		77	107	137	167
18		48		78	108	138	168
19		49		79	109	139	169
20		50		80	110	140	170
21		51		81	111	141	171
22		52		82	112	142	172
23		53		83	113	143	173
24		54		84	114	144	174
25		3	55	85	115	145	175
26		4	56	86	116	146	176
27		5	57	87	117	147	177
28		6	58	88	118	148	178
29		7	59	89	119	149	179
2	30	8	60	90	120	150	180